

**Search Notes**

Application/Control No.

10/762,934

Examiner

Paul R. Myers

Applicant(s)/Patent under  
Reexamination

CHEN, BEN WEI

Art Unit

2112

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East searched see attached	3/7/2006	PRM